International Rectifier

- Application Specific MOSFETs
- Ideal for CPU Core DC-DC Converters
- Low Conduction Losses
- High Cdv/dt Immunity
- Low Profile (<0.7 mm)
- Dual Sided Cooling Compatible
- Compatible with existing Surface Mount Techniques

Description

30V



PD - 94574A

50nC

IRF6607

HEXFET® Power MOSFET

V_{DSS} R_{DS(on)} max Qg

 $3.3m\Omega@V_{GS} = 10V$

 $4.4 \text{m}\Omega @V_{GS} = 4.5 \text{V}$

The IRF6607 combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest on-state resistance in a package that has the footprint of an SO-8 and only 0.7 mm profile. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, IMPROVING previous best thermal resistance by 80%.

The IRF6607 balances both low resistance and low charge along with ultra low package inductance to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors operating at higher frequencies. The IRF6607 has been optimized for parameters that are critical in synchronous buck converters including Rds(on), gate charge and Cdv/dt-induced turn on immunity. The IRF6607 offers particularly low Rds(on) and high Cdv/dt immunity for synchronous FET applications.

Absolute Maximum Ratings

	Parameter	Max.	Units	
V_{DS}	Drain-to-Source Voltage	30	V	
V _{GS}	Gate-to-Source Voltage	±12		
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	94		
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	27	А	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	22		
I _{DM}	Pulsed Drain Current ①	220		
P _D @T _A = 25°C	Power Dissipation ®	3.6		
P _D @T _A = 70°C	Power Dissipation ®	2.3	W	
P _D @T _C = 25°C	Power Dissipation	42		
	Linear Derating Factor	0.029	W/°C	
T _J	Operating Junction and	-40 to + 150	°C	
T _{STG}	Storage Temperature Range			

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ④		35	
$R_{\theta JA}$	Junction-to-Ambient ©	12.5	_	
$R_{\theta JA}$	Junction-to-Ambient ®	20	_	°C/W
$R_{\theta JC}$	Junction-to-Case ⑦		3.0	
$R_{\theta J\text{-PCB}}$	Junction-to-PCB Mounted		1.0	1

Notes ① through ⑦ are on page 11 www.irf.com

IRF6607

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Static @ T_J = 25°C (unless otherwise specified)

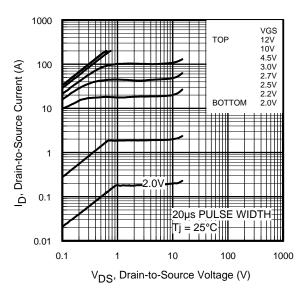
	Parameter	Min.	Тур.	Max.	Units	Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	30	_		٧	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta \mathrm{BV}_\mathrm{DSS}\!/\!\Delta \mathrm{T}_\mathrm{J}$	Breakdown Voltage Temp. Coefficient		29		mV/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		2.5	3.3	mΩ	V _{GS} = 10V, I _D = 25A ③
			3.4	4.4	1	V _{GS} = 4.5V, I _D = 20A ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0			V	$V_{DS} = V_{GS}, I_{D} = 250\mu A$
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Coefficient		-5.3		mV/°C	
I _{DSS}	Drain-to-Source Leakage Current			30	μΑ	V _{DS} = 24V, V _{GS} = 0V
				100	1	$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 70^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 12V
	Gate-to-Source Reverse Leakage			-100		V _{GS} = -12V
gfs	Forward Transconductance	120			S	$V_{DS} = 15V, I_{D} = 20A$
Q_g	Total Gate Charge		50	75		
Q_{gs1}	Pre-Vth Gate-to-Source Charge	_	13	_		$V_{DS} = 15V$
Q_{gs2}	Post-Vth Gate-to-Source Charge	_	4.0	_	nC	$V_{GS} = 4.5V$
Q_{gd}	Gate-to-Drain Charge		16			I _D = 20A
Q_{godr}	Gate Charge Overdrive	_	18	_		See Fig. 16
Q_{sw}	Switch Charge (Q _{gs2} + Q _{gd})	_	20	_		
Q _{oss}	Output Charge	_	30	_	nC	$V_{DS} = 16V, V_{GS} = 0V$
t _{d(on)}	Turn-On Delay Time		60			V _{DD} = 15V, V _{GS} = 4.5V ③
t _r	Rise Time		8.0		1	I _D = 20A
t _{d(off)}	Turn-Off Delay Time		32		ns	Clamped Inductive Load
t _f	Fall Time		13			
C _{iss}	Input Capacitance		6930			V _{GS} = 0V
C _{oss}	Output Capacitance		1260		pF	V _{DS} = 15V
C _{rss}	Reverse Transfer Capacitance		510		1	f = 1.0MHz

Avalanche Characteristics

	Parameter	Тур.	Max.	Units
E _{AS}	Single Pulse Avalanche Energy ^②		51	mJ
I _{AR}	Avalanche Current ①		20	Α
E _{AR}	Repetitive Avalanche Energy ①		0.36	mJ

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			27		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current	—	_	220		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage		1.0	1.3	V	$T_J = 25$ °C, $I_S = 20$ A, $V_{GS} = 0$ V ③
t _{rr}	Reverse Recovery Time		46	69	ns	$T_J = 25^{\circ}C, I_F = 20A$
Q_{rr}	Reverse Recovery Charge		54	81	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

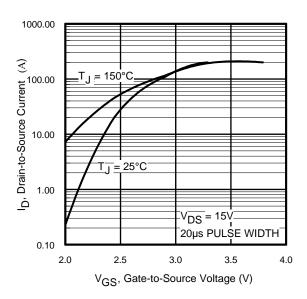


1000

(V) tuesuro 100

Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



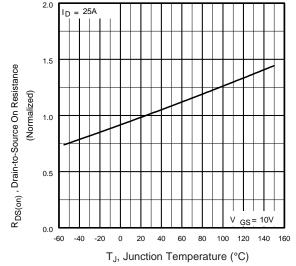


Fig 3. Typical Transfer Characteristics

Fig 4. Normalized On-Resistance vs. Temperature

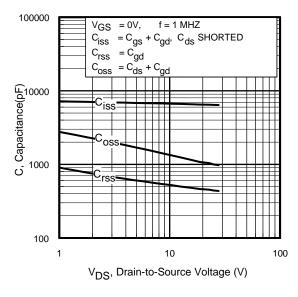


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

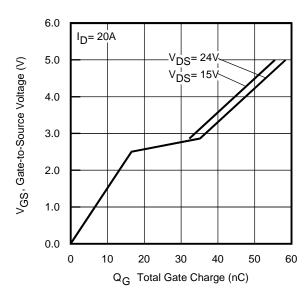


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

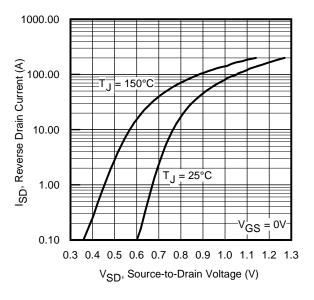


Fig 7. Typical Source-Drain Diode Forward Voltage

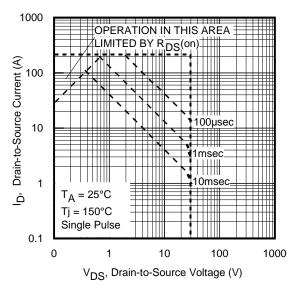
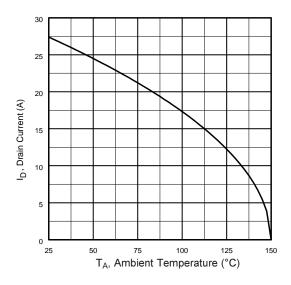


Fig 8. Maximum Safe Operating Area



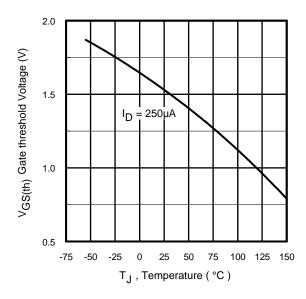


Fig 9. Maximum Drain Current Vs. Ambient Temperature

Fig 10. Threshold Voltage Vs. Temperature

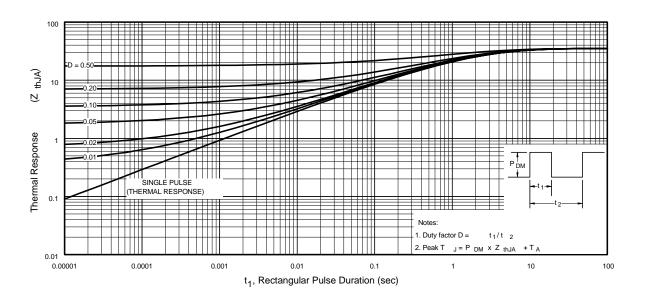


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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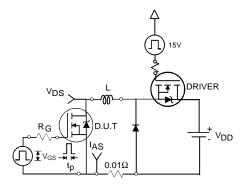


Fig 12a. Unclamped Inductive Test Circuit

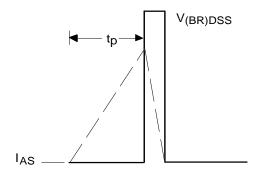


Fig 12b. Unclamped Inductive Waveforms

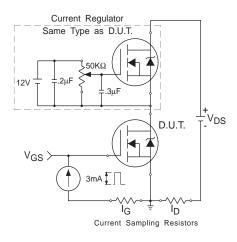


Fig 13. Gate Charge Test Circuit

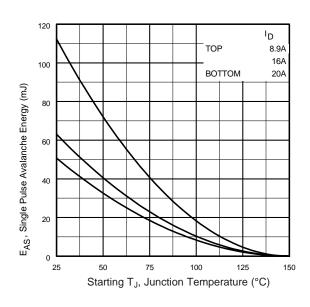


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

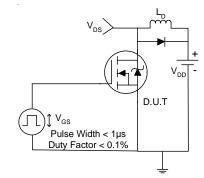


Fig 14a. Switching Time Test Circuit

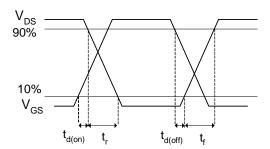


Fig 14b. Switching Time Waveforms www.irf.com

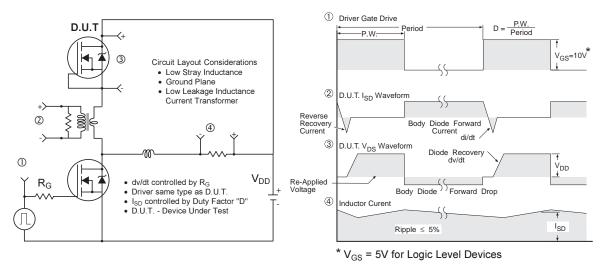


Fig 15. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

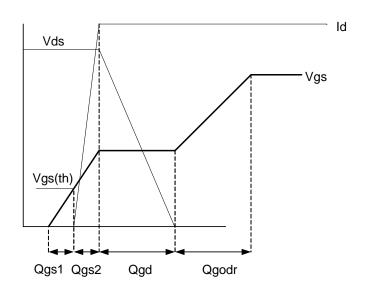


Fig 16. Gate Charge Waveform

Power MOSFET Selection for Non-Isolated DC/DC Converters

Control FET

Special attention has been given to the power losses in the switching elements of the circuit - Q1 and Q2. Power losses in the high side switch Q1, also called the Control FET, are impacted by the $R_{\rm ds(on)}$ of the MOSFET, but these conduction losses are only about one half of the total losses.

Power losses in the control switch Q1 are given by;

$$P_{loss} = P_{conduction} + P_{switching} + P_{drive} + P_{output}$$

This can be expanded and approximated by:

$$\begin{split} P_{loss} &= \left(I_{rms}^{2} \times R_{ds(on)}\right) \\ &+ \left(I \times \frac{Q_{gd}}{i_{g}} \times V_{in} \times f\right) + \left(I \times \frac{Q_{gs2}}{i_{g}} \times V_{in} \times f\right) \\ &+ \left(Q_{g} \times V_{g} \times f\right) \\ &+ \left(\frac{Q_{oss}}{2} \times V_{in} \times f\right) \end{split}$$

This simplified loss equation includes the terms ${\rm Q_{gs2}}$ and ${\rm Q_{oss}}$ which are new to Power MOSFET data sheets.

 Q_{gs2} is a sub element of traditional gate-source charge that is included in all MOSFET data sheets. The importance of splitting this gate-source charge into two sub elements, Q_{gs1} and Q_{gs2} , can be seen from Fig 16.

 Q_{gs2} indicates the charge that must be supplied by the gate driver between the time that the threshold voltage has been reached and the time the drain current rises to I_{dmax} at which time the drain voltage begins to change. Minimizing Q_{gs2} is a critical factor in reducing switching losses in Q1.

 $Q_{\mbox{\tiny oss}}$ is the charge that must be supplied to the output capacitance of the MOSFET during every switching cycle. Figure A shows how $Q_{\mbox{\tiny oss}}$ is formed by the parallel combination of the voltage dependant (nonlinear) capacitance's $C_{\mbox{\tiny ds}}$ and $C_{\mbox{\tiny dg}}$ when multiplied by the power supply input buss voltage.

Synchronous FET

The power loss equation for Q2 is approximated by:

$$\begin{split} P_{loss} &= P_{conduction} + P_{drive} + P_{output}^* \\ P_{loss} &= \left(I_{rms}^2 \times R_{ds(on)}\right) \\ &+ \left(Q_g \times V_g \times f\right) \\ &+ \left(\frac{Q_{oss}}{2} \times V_{in} \times f\right) + \left(Q_{rr} \times V_{in} \times f\right) \end{split}$$

*dissipated primarily in Q1.

For the synchronous MOSFET Q2, $R_{\rm ds(on)}$ is an important characteristic; however, once again the importance of gate charge must not be overlooked since it impacts three critical areas. Under light load the MOSFET must still be turned on and off by the control IC so the gate drive losses become much more significant. Secondly, the output charge Q_{oss} and reverse recovery charge Q_{rr} both generate losses that are transfered to Q1 and increase the dissipation in that device. Thirdly, gate charge will impact the MOSFETs' susceptibility to Cdv/dt turn on.

The drain of Q2 is connected to the switching node of the converter and therefore sees transitions between ground and $V_{\rm in}.$ As Q1 turns on and off there is a rate of change of drain voltage dV/dt which is capacitively coupled to the gate of Q2 and can induce a voltage spike on the gate that is sufficient to turn the MOSFET on, resulting in shoot-through current . The ratio of $Q_{\rm gd}/Q_{\rm gs1}$ must be minimized to reduce the potential for Cdv/dt turn on.

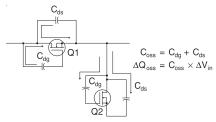


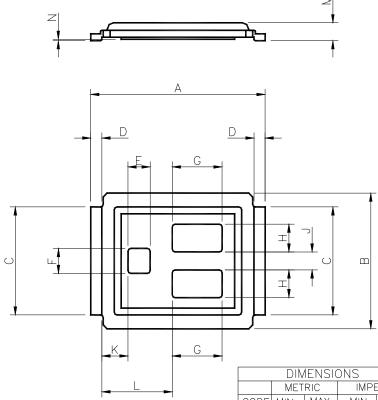
Figure A: Q_{oss} Characteristic

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IRF6607

DirectFET™ Outline Dimension, MT Outline (Medium Size Can, T-Designation).



Note: Controlling dimensions are in mm

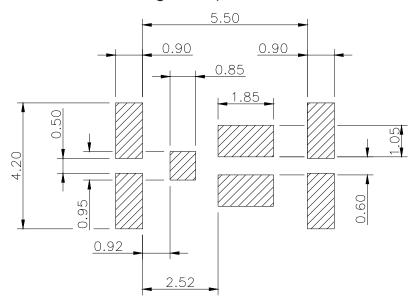
	METRIC		IMP	-RIAL
CODE	MIN	MAX	MIN	MAX
А	6.25	6.35	0.246	0.250
В	4.80	5.05	0.189	0.201
С	3.85	3.95	0.152	0.156
D	0.35	0.45	0.014	0.018
E	0.78	0.82	0.031	0.032
F	0.88	0.92	0.035	0.036
G	1.78	1.82	0.070	0.072
Н	0.98	1.02	0.039	0.040
J	0.63	0.67	0.025	0.026
K	0.88	1.01	0.035	0.039
L	2.46	2.63	0.097	0.104
М	0.59	0.70	0.023	0.028
N	0.03	0.08	0.001	0.003

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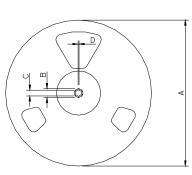
DirectFET™ Board Footprint, MT Outline (Medium Size Can, T-Designation).



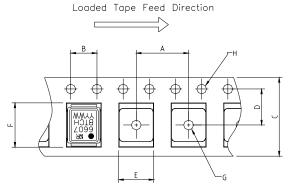
DirectFET™ Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as IRF6607), For 1000 parts on 7" reel, order IRF6607TR1



DIMENSIONS							
	ME	TRIC	IMP	IMPERIAL			
CODE	MIN	MAX	MIN	MAX			
Α	330.0	N.C	12.992	N.C			
В	20.2	N.C	0.795	N.C			
С	12.8	13.2	0.504	0.520			
D	1.5	N.C	0.059	N.C			
E	100.0	N.C	3.937	N.C			
F	N.C	18.4	N.C	0.724			
G	12.4	14.4	0.488	0.567			
Н	11.9	15.4	0.469	0.606			

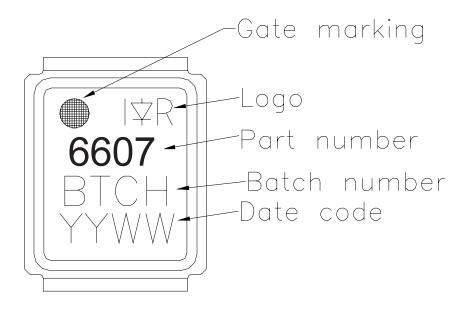


OTE: CONTROLLING		
IMENSIONS IN MM	CODE	MI
INCINSIONS IN MIN	A	7.
	В	3.
	С	11.9
	D	5

	METRIC		IMP	ERIAL
CODE	MIN	MAX	MIN	MAX
Α	7.90	8.10	0.311	0.319
В	3.90	4.10	0.154	0.161
С	11.90	12.30	0.469	0.484
D	5.45	5.55	0.215	0.219
E	5.10	5.30	0.201	0.209
F	6.50	6.70	0.256	0.264
G	1.50	N.C	0.059	N.C
Н	1.50	1.60	0.059	0.063

DIMENSIONS

DirectFET™ Part Marking



Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25$ °C, L = 0.25mH $R_G = 25\Omega$, $I_{AS} = 20A$.
- 3 Pulse width \leq 400 μ s; duty cycle \leq 2%.
- ④ Surface mounted on 1 in. square Cu board.
- ⑤ Used double sided cooling, mounting pad.
- 6 Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- T_C measured with thermal couple mounted to top (Drain) of part.

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualification Standards can be found on IR's Web site.



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